

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination EYER, MARK KENNETH	
		Examiner Nam V. Nguyen	Art Unit 2612	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,229,433	05-2001	Rye et al.	340/310.12
	B	US-			
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NON-PATENT DOCUMENTS

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